
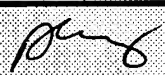



Issue Classification 	Application No.	Applicant(s)	
	10/078,714	CHEN ET AL.	
	Examiner	Art Unit	
	Yaritza Guadalupe McCall	2859	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
33		265		33	263	87			
INTERNATIONAL CLASSIFICATION									
F	4	1	G						
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Yaritza Guadalupe 10/13/2004 (Assistant Examiner) (Date)	 Diego Gutierrez Supervisory Patent Examiner Technology Center 2800 (Primary Examiner) (Date)	Total Claims Allowed: 9	
 (Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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